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	Application Number	10/652,586
	Filing Date	August 29, 2003
	First Named Inventor	Charles W. Extrand
	Art Unit	375a
	Examiner Name	Hook
١	Attorney Docket Number	2267 85411501

				Examiner Name HOOK		Examiner Name HOOK		l Hook
Sheet	1	of	7	7	Attorney Docket Number	2267.854US01		
			U.S. PA	TENT	DOCUMENTS			
EXAMINER INITIAL*	Cite No.1	Document Number			Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		
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EXAMINER INITIAL*	Cite No. <sup>1</sup>	Foreign Patent Document  Country Code <sup>3</sup> Number <sup>4</sup> Kind Code <sup>5</sup> (if known)		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	T <sup>6</sup>		
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Sheet 5 of 7 Attorney Docket Number 2267.854US01		2267.854US01									
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